ISI IDEAL SEMICONDUCTOR INC.

"Your Best Defense Against Obsolescence"

OBJECTIVE SPECIFICATIONS

Features

- *Function, pin-out, speed and drive compatability with 54/74ALS logic family*
- *Low power consumption characteristic of CMOS*
- *High-Drive-Current outputs:* I_{OL} = 8 mA @ V_{OL} = 0.5V
- *Inputs and outputs interface directly with TTL, NMOS and CMOS devices*
- *Wide operating voltage range: 4.5V to 5.5V*
- *Characterized for operation over industial and military temperature ranges:*

  74AHCT: -40°C to +85°C
  54AHCT: -55°C to +125°C

Function Table

Inputs				Outputs	
$\overline{CLR}$	CLK	J	K	Q	$\bar{Q}$
L	X	X	X	L	H
H	↓	L	L	Q_o	Q_o
H	↓	H	L	H	L
H	↓	L	H	L	H
H	↓	H	H	TOGGLE	
H	H	X	X	Q_o	Q_o

Dual J-K Negative-Edge-Triggered Flip-Flops with Clear

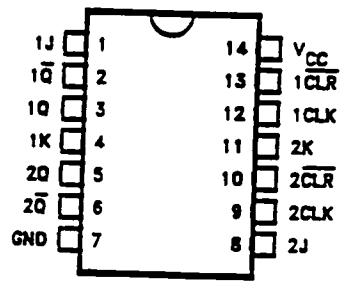
Description

These devices contain two independent J-K negative-edge-triggered flip-flops. A low level at the $\overline{CLR}$ input resets the outputs regardless of the levels of the other inputs. When $\overline{CLR}$ is inactive (high), data at the J and K inputs meeting the setup time requirements are transferred to the outputs on the negative-ongoing edge of clock pulse. Clock triggering occurs at a voltage level is not directly releated to the rise time of the clock pulse. Following the hold time interval, data at the J and K inputs may be changed without affecting the levels at the outputs. These versatile flip-flops can perform as toggle flip-flops by tying J and K high.

Fabrication using ISI proprietary ICE-MOS process, these devices provide speeds and drive capability equivalent to their ALSTTL counterparts and yet maintain CMOS power levels. The input and output voltage levels allow direct interface with TTL, NMOS and CMOS devices without any external components.

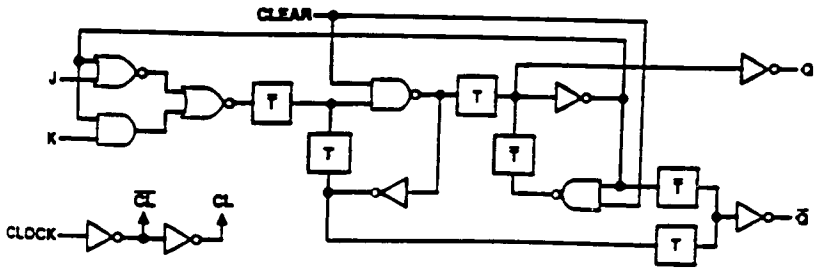
All inputs and outputs are protected from damage due to static discharge by internal diode clamps to V_{CC} and ground.

Pin Configuration



0018-1

Logic Diagrams



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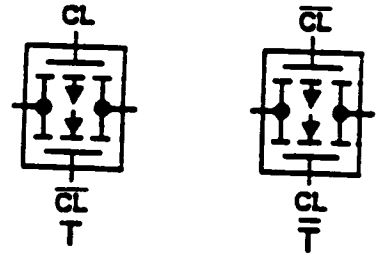

0018-3

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Absolute Maximum Ratings*

Supply Voltage Range, V_{CC} .....-0.5V to 7V
DC Input Diode Current, I_{IK}
(V_I <-0.5V or V_I >V_{CC} + 0.5V).....±20 mA
DC Output Diode Current, I_{OK}
(V_O <-0.5V or V_O>V_{CC} + 0.5V).....±20 mA
Continuous Output Current Per Pin, I_O
(-0.5V <V_O<V_{CC} + 0.5V).....±35 mA
Continuous Current Through
V_{CC} or GND pins.....±125 mA
Storage Temperature Range, T_{STG} .....-65°C to +150°C
Power Dissipation Per Package, P_D•.....500 mW

*Absolute Maximum Ratings are those values beyond which permanent damage to the device may occur. These are stress ratings only and functional operation of the device at or beyond them is not implied. Long exposure to these conditions may affect device reliability.

•Power Dissipation temperature derating:
Plastic Package (N): -12mW/°C from 65°C to 85°C
Ceramic Package (J): -12mW/°C from 100°C to 125°C

Recommended Operating Conditions

Supply Voltage, V_{CC} .....4.5V to 5.5V
DC Input & Output Voltages*, V_{IN}, V_{OUT} .....0V to V_{CC}

Operating Temperature

Range 74AHCT: -40°C to +85°C
54AHCT: -55°C to +125°C

Input Rise & Fall Times, t_r , t_f .....Max 500 ns

*Unused inputs must always to tied to an appropriate logic voltage level (either V_{CC} or GND)

DC Electrical Characteristics (V_{CC} = 5V ±10% Unless Otherwise Specified)

Sym	Parameter	Test Conditions	T_A = 25°C	74AHCT T_A = -40°C to +85°C	54AHCT T_A = -55°C to +125°C	Unit
			Typ	Guaranteed Limits		
V_{IH}	Minimum High-Level Input Voltage			2.0	2.0	2.0	V
V_{IL}	Maximum Low-Level Input Voltage			0.8	0.8	0.8	V
V_{OH}	Minimum High-Level Output Voltage	V_{IN} = V_{IH} or V_{IL} I_O = -20 µA I_O = -4 mA	 V_{CC} 4.2	 V_{CC} - 0.1 3.98	 V_{CC} - 0.1 3.84	 V_{CC} - 0.1 3.7	V
V_{OL}	Maximum Low-Level Output Voltage	V_{IN}= V_{IH} or V_{IL} I_O = 20 µA I_O = 4 mA I_O = 8 mA	 0	 0.1 0.26 0.39	 0.1 0.33 0.5	 0.1 0.4	V
I_{IN}	Maximum Input Current	V_{IN} = V_{CC} or GND		±0.1	±1.0	±1.0	µA
I_{CC}	Maximum Quiescent Supply Current	V_{IN} = V_{CC} or GND I_{OUT} = 0 µA		4.0	40.0	80.0	µA

AC Electrical Characteristics (Input t_r, $t_f \leq 2$ ns), AHCT107

Sym	Parameter	Conditions •	T_A = 25°C VCC - 5.0V	74AHCT T_A = -40°C to +85°C V_{CC} = 5.0V ±10%	54AHCT T_A = -55°C to +125°C V_{CC} = 5.0V ±10%	Unit
			Typ	Guaranteed Limits		
f_{max}	Maximum Clock Frequency	C_L = 50 pF	45	30	25	MHz
t_{PLH}	Maximum Propagation Delay, CLK to Q or $\bar{Q}$		10	17	20	ns
t_{PHL}			10	17	20	
t_{PLH}	Maximum Propagation Delay, $\overline{CLR}$ to Q or $\bar{Q}$		10	17	20	ns
t_{PHL}			10	17	20	
t_{su}	Minimum Setup Time before CLK ↓ — J or K		10	17	20	ns
	Minimum Setup Time before CLK ↓ — $\overline{CLR}$ Inactive		10	17	20	
t_h	Minimum Hold Time, J or K after CLK↓		0	0	0	ns
t_w	Minimum Pulse Width — CLK High or Low		8	13	15	ns
	Minimum Pulse Width — $\overline{CLR}$ Low		8	13	15	
C_{IN}	Maximum Input Capacitance		5			pF
C_{PD}	Power Dissipation Capacitance*	(per flip-flop)	40			pF

*C_{PD} determines the no-load dynamic power consumption: $P_D = C_{PD}\ V_{CC}^2\ f + I_{CC}\ V_{CC}$
•For AC switching test circuits and timing waveforms see section 2.